

Substitute for form 1449/PTO <h2 style="text-align: center;">INFORMATION DISCLOSURE STATEMENT BY APPLICANT</h2> <p style="text-align: center;">(use as many sheets as necessary)</p>				Complete if Known <table border="1" style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 50%;">Application Number</td> <td>10/558,434</td> </tr> <tr> <td>Filing Date</td> <td>November 29, 2005</td> </tr> <tr> <td>First Named Inventor</td> <td>Sam-Chul HA</td> </tr> <tr> <td>Art Unit</td> <td>2471</td> </tr> <tr> <td>Examiner Name</td> <td>Albert T. Chou</td> </tr> <tr> <td>Attorney Docket Number</td> <td>7950.036.00</td> </tr> </table>		Application Number	10/558,434	Filing Date	November 29, 2005	First Named Inventor	Sam-Chul HA	Art Unit	2471	Examiner Name	Albert T. Chou	Attorney Docket Number	7950.036.00
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U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/A.C.	AA	US 4,928,245	05-22-1990	Moy et al.		
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Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ² -Number ³ -Kind Code ⁴ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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NON PATENT LITERATURE DOCUMENTS						
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Examiner Signature	/Albert Chou/	Date Considered	01/06/2011
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